Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,173	CHAN, FRANK A.	
Examiner	Art Unit	
Amy T. Lang	3731	


SEARCHED			
Class	Subclass	Date	Examiner
606	181	12/22/2006	ATL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO' (INCLUDING SEARCH		
	DATE	EXMR
Inventor Search	12/22/2006	ATL
EAST keyword search: see attached	12/22/2006	ATL
606/181 (text delimited search: see attached)	12/22/2006	ATL
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